SLOS010B - MARCH 1987 - REVISED AUGUST 1994

Low Input Bias Current . . . 50 pA Typ

- Low Input Noise Current 0.01 pA/√Hz Typ
- Low Supply Current . . . 4.5 mA Typ
- High Input impedance . . . $10^{12} \Omega$ Typ
- Internally Trimmed Offset Voltage
- Wide Gain Bandwidth . . . 3 MHz Typ
- High Slew Rate . . . 13 V/μs Typ

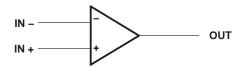
description

This device is a low-cost, high-speed, JFET-input operational amplifier with very low input offset voltage and a specified maximum input offset voltage drift. It requires low supply current yet maintains a large gain bandwidth product and a fast slew rate. In addition, the matched high-voltage JFET input provides very low input bias and offset currents.

The LF412C can be used in applications such as high-speed integrators, digital-to-analog converters, sample-and-hold circuits, and many other circuits.

The LF412C is characterized for operation from 0°C to 70°C.

symbol (each amplifier)



AVAILABLE OPTIONS

| | Viemov | PACKAGE | | | | | |
|-------------|--------------------------------|----------------------|--------------------|--|--|--|--|
| TA | V _{IO} max AT 25°C | SMALL OUTLINE (D) | PLASTIC DIP (P) | | | | |
| 0°C to 70°C | 3 mV | LF412CD | LF412CP | | | | |

The D packages are available taped and reeled. Add the suffix R to the device type (ie., LF412CDR).

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

| Supply voltage, V _{CC+} | 18 V |
|--|----------------|
| Supply voltage, V _{CC} | |
| Differential input voltage, V _{ID} | ±30 V |
| Input voltage, V _I (see Note 1) | ±15 V |
| Duration of output short circuit | unlimited |
| Continuous total power dissipation | 500 mW |
| Operating temperature range | 0°C to 70°C |
| Storage temperature range | –65°C to 150°C |
| Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds | 260°C |
| | |

NOTE 1: Unless otherwise specified, the absolute maximum negative input voltage is equal to the negative power supply voltage.



LF412C DUAL JFET-INPUT OPERATIONAL AMPLIFIER

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recommended operating conditions

| | MIN | MAX | UNIT |
|-----------------------------------|------|-----|------|
| Supply voltage, V _{CC +} | 3.5 | 18 | V |
| Supply voltage, V _{CC} _ | -3.5 | -18 | V |

electrical characteristics over operating free-air temperature range, $V_{CC\pm}$ = ± 15 V (unless otherwise specified)

| | PARAMETER | TEST C | CONDITIONS | T _A † | MIN | TYP | MAX | UNIT |
|------|---|---------------------------|------------------------|------------------|-----|---------------------|-----|-------|
| VIO | Input offset voltage | V _{IC} = 0, | R _S = 10 kΩ | 25°C | | 1 | 3 | mV |
| ανιο | Average temperature coefficient of input offset voltage | V _{IC} = 0, | R _S = 10 kΩ | | | 10 | 20‡ | μV/°C |
| | | ., . | | 25°C | | 25 | 100 | рА |
| liO | Input offset current§ | Λ IC = 0 | | 70°C | | | 4 | nA |
| | | | | 25°C | | 50 | 200 | рА |
| IB | Input bias current\$ | VIC = 0 | | 70°C | | | 8 | nA |
| VICR | Common-mode input voltage range | | | | ±11 | -11.5 to 14.5 | | V |
| VOМ | Maximum peak output voltage swing | R _L = 10 kΩ | | | ±12 | ±13.5 | | V |
| | | | D 0 10 | 25°C | 25 | 200 | | |
| AVD | Large-signal differential voltage | $V_0 = \pm 10 \text{ V},$ | $R_L = 2 k\Omega$ | Full range | 15 | 200 | | V/mV |
| rį | Input resistance | T _A = 25°C | | | | 10 ¹² | | Ω |
| CMRR | Common-mode rejection ratio | R _S ≤ 10 kΩ | | | 70 | 100 | | dB |
| ksvr | Supply-voltage rejection ratio | See Note 2 | | | 70 | 100 | | dB |
| Icc | Supply current | | | | | 4.5 | 6.8 | mA |
| | | | | | | | | |

[†] Full range is 0°C to 70°C.

operating characteristics, $V_{CC\pm}$ = ±15 V, T_A = 25°C

| | PARAMETER | TEST CON | NDITIONS | MIN | TYP | MAX | UNIT |
|----------------------------------|--------------------------------|------------|-------------------|-----|------|-----|--------------------|
| V _{O1} /V _{O2} | Crosstalk attenuation | f = 1 kHz | | | 120 | | dB |
| SR | Slew rate | | | 8 | 13 | | V/μs |
| B ₁ | Unity-gain bandwidth | | | 2.7 | 3 | | MHz |
| Vn | Equivalent input noise voltage | f = 1 kHz, | $R_S = 20 \Omega$ | | 18 | | nV/√ Hz |
| In | Equivalent input noise current | f = 1 kHz | _ | | 0.01 | | pA/√ Hz |

[‡] At least 90% of the devices meet this limit for α_{VIO} .

[§] Input bias currents of a FET-input operational amplifier are normal junction reverse currents, which are temperature sensitive. Pulse techniques must be used that will maintain the junction temperatures as close to the ambient temperature as possible.

NOTE 2: Supply-voltage rejection ratio is measured for both supply magnitudes increasing or decreasing simultaneously.





19-Jul-2016

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|--------|--------------|--------------------|------|----------------|----------------------------|------------------|--------------------|--------------|----------------------|---------|
| LF412 MWC | ACTIVE | WAFERSALE | YS | 0 | 1 | Green (RoHS & no Sb/Br) | Call TI | Level-1-NA-UNLIM | -40 to 85 | , co | Samples |
| LF412CD | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | 0 to 70 | LF412C | Samples |
| LF412CDE4 | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | 0 to 70 | LF412C | Samples |
| LF412CDG4 | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | 0 to 70 | LF412C | Samples |
| LF412CDR | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | 0 to 70 | LF412C | Samples |
| LF412CDRE4 | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | 0 to 70 | LF412C | Samples |
| LF412CDRG4 | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | 0 to 70 | LF412C | Samples |
| LF412CP | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | 0 to 70 | LF412CP | Samples |
| LF412CPE4 | ACTIVE | PDIP | Р | 8 | 50 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | 0 to 70 | LF412CP | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



PACKAGE OPTION ADDENDUM

19-Jul-2016

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION





| Α | 0 | Dimension designed to accommodate the component width |
|----|---|---|
| В | 0 | Dimension designed to accommodate the component length |
| | | Dimension designed to accommodate the component thickness |
| ٧ | ٧ | Overall width of the carrier tape |
| ГР | 1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | _ | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|----------|------|--------------------|---|------|--------------------------|--------------------------|---------|---------|---------|------------|-----------|------------------|
| LF412CDR | SOIC | D | 8 | 2500 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |





*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) | |
|----------|--------------|-----------------|------|------|-------------|------------|-------------|--|
| LF412CDR | SOIC | D | 8 | 2500 | 340.5 | 338.1 | 20.6 | |



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001 variation BA.



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